

Wide tuning range CMOS Colpitts VCO based on tunable active inductor

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ABSTRACT:

In this paper, a new differential Colpitts voltage-controlled oscillator (VCO) is presented. The VCO is based on the gm-boosted structure to relax the oscillation start-up current requirement and reduce the DC power consumption in comparison to conventional Colpitts structures. In the proposed VCO, a tunable active inductor is utilized as a part of LC tank instead of passive inductor with constant inductance. The proposed VCO is designed and simulated in ADS in a 0.18 μm CMOS process. Simulation results indicate that the proposed VCO has a wide tuning range in comparison to other reported designs while consumes less DC power.

KEYWORDS: CMOS, Colpitts, Tunable Active Inductor, voltage-controlled oscillator (VCO), Wide Tuning Range.

1. INTRODUCTION

Frequency of the voltage-controlled oscillators (VCOs) based on LC tank is tuned by changing the capacitance of the tank; because in a fully integrated architecture, changing the inductance value is not possible. Tunable capacitors are based on pn-junction varactors or accumulation-mode MOS varactors in which the value of capacitance is changed by tuning the DC bias of the varactor. However, the VCOs based on this kind of tuning system suffer from limited tuning range between 10%-30% [1], [2]. Using a tunable active inductor instead of passive one is a suitable choice to enhance the tuning range of the VCO.

Today, tunable active inductors have attracted great attention in designing filters, phase shifters, VCOs, and injection-locked frequency dividers (ILFDs) [3]-[5]. At low gigahertz, passive inductors occupy large chip area and increase the cost. So, using the active inductor helps to achieve lower cost and wide tuning range chip. Although, the active inductor-based VCO has a wide tuning range, it has higher phase noise in comparison to its passive inductor-based one. But, due to the fact that this kind of VCO is the core of the wide locking range ILFD, designing an active inductor-based VCO should be taken into consideration [6], [7].

This paper presents the design procedure of a new differential Colpitts VCO based on active inductor. Simulation results indicate that the proposed VCO has a wide tuning range and high output power in comparison to other reported designs while consumes

less DC power. The proposed architecture is capable to be used as the core of the wide locking range ILFDs.

2. CIRCUIT DESIGN

2.1. Active Inductor

The block diagram of the active inductor based on the gyrator-C theorem is shown in Fig. 1(a). Two transconductors connected in back-to-back, form a gyrator. The transconductor in the forward path has a negative transconductance and the one in the feedback path has a positive transconductance. By replacing the common-source and common-drain architectures for the transconductors, the circuit level realization of the active inductor can be achieved as shown in Fig. 1(b) [8]. M_n and M_p act as current sources for biasing the circuit. But, this active inductor suffers from fixed low inductance, low quality factor, and limited tuning range. To enhance the performance of the circuit, an active tunable resistor (R_f) can be used at the gate of M_2 . This resistor consists of the parallel connection of a NMOS transistor M_R and a passive resistor (R_p) which its resistance is usually large (Fig. 2(a)) [9]. The resistance of the active tunable resistor can be controlled by changing the gate-source voltage of the parallel transistor. The tuning capability of the active resistor versus control voltage V_{tune} in 0.18 μm CMOS process is shown in Fig. 2(b).

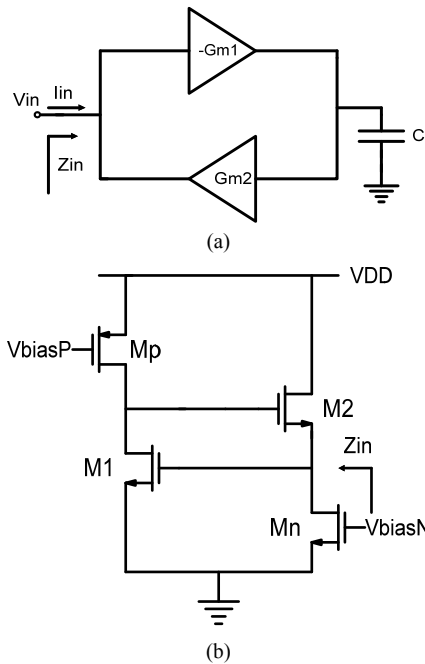


Fig. 1. (a) Block diagram, (b) circuit level realization

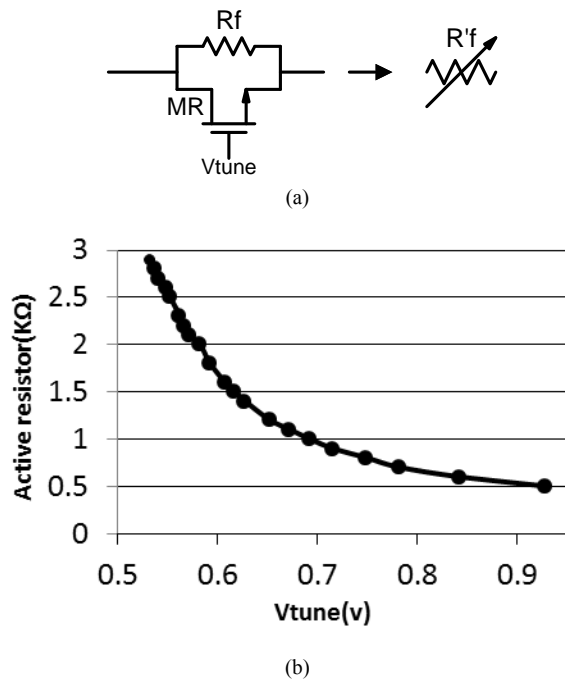


Fig. 2. (a) Active resistor structure, (b) tuning capability of the active resistor versus control voltage

As it is obvious from Fig. 2, the resistance will be decreased when V_{tune} is increased.

For deep consideration of how the active inductor works, the complete schematic of the inductor and its equivalent circuits are shown in Fig. 3 [10]. As it can

be seen, the active inductor of Fig. 3(a) can be modeled as a RLC network of Fig. 3(b) and its small signal model is shown in Fig. 3(c) where g_{dsp} and g_{dsn} are output conductance of transistors Mp and Mn, respectively, g_{m1} and g_{m2} are transconductance of the gyrator main transistors M1 and M2, and C_{gs1} and C_{gs2} are their gate-source capacitance.

The relations of equivalent RLC model are as below [10]:

$$R_{eq} = \frac{g_{dsp}}{(g_{m1}g_{m2} + g_{m2}g_{dsp} + g_{dsn}g_{dsp})} \quad (1)$$

$$L_{eq} = \frac{C_{gs2}(1 + R_f g_{dsp})}{(g_{m1}g_{m2} + g_{m2}g_{dsp} + g_{dsn}g_{dsp})} \quad (2)$$

$$C_{eq} = \frac{C_{gs2}[g_{m1} + g_{dsp} + g_{dsn}(1 + R_f g_{dsp})] + C_{gs1}g_{dsp}}{(g_{m1}g_{m2} + g_{m2}g_{dsp} + g_{dsn}g_{dsp})R_{eq}} \quad (3)$$

According to (2), when the control voltage V_{tune} is increased which is equivalent to decreasing the tunable resistor R_f , the equivalent inductance L_{eq} will be decreased. So, this issue is suitable for designing a new VCO with tunable active inductor.

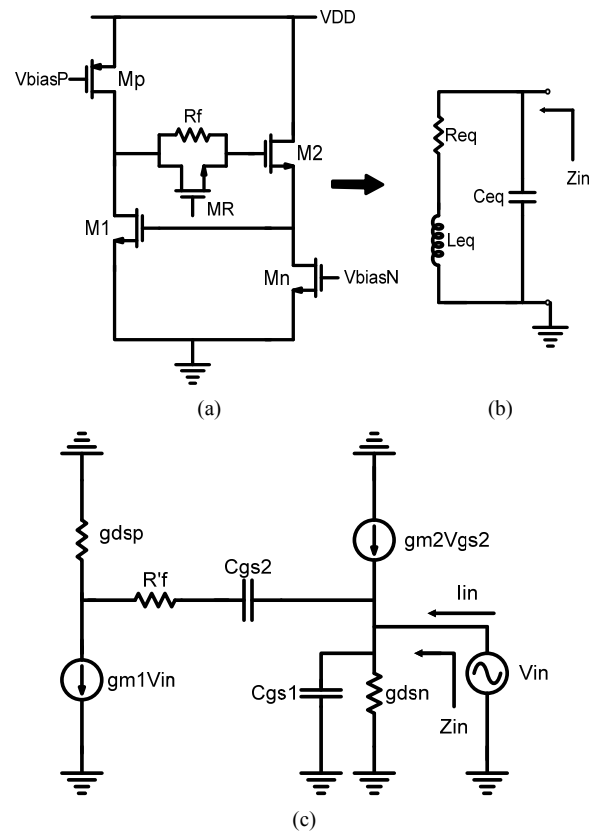


Fig. 3. Tunable active inductor, (a) circuit level, (b) equivalent RLC model, (c) small signal model

proposed VCO is provided in Table I.

Table II provides a comparison of the proposed VCO and recently works [12]-[14]. As it can be seen, the proposed VCO has much wider tuning range of 149% and higher output power in comparison to other designs while it dissipates less DC power. Also, its phase noise is comparable with some works.

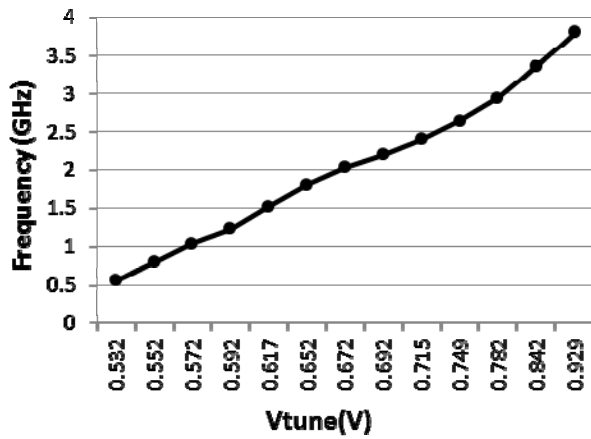


Fig. 6. Oscillation frequency of the VCO versus V_{tune}

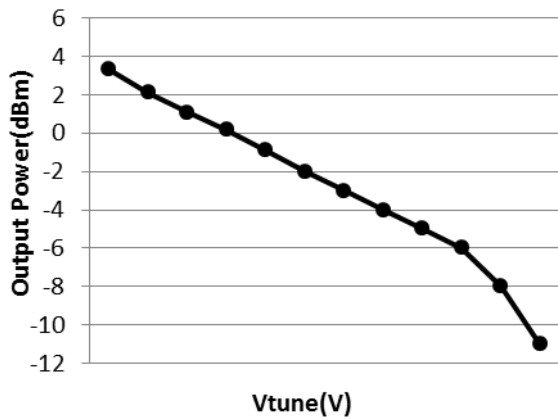


Fig. 7. Output power of the VCO versus V_{tune}

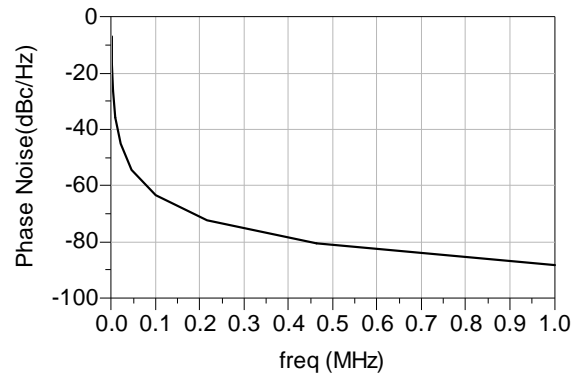


Fig. 8. Phase noise of the VCO at 1.1GHz for $V_{tune} = 0.572V$

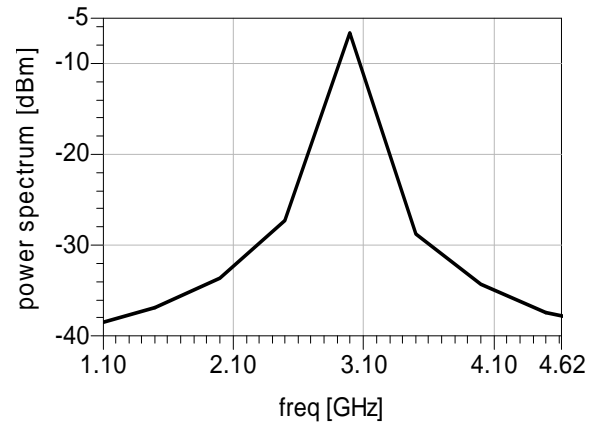


Fig. 9. Output power spectrum of the VCO at $V_{tune} = 0.782V$

Table I. Brief summary of the specifications

Supply Voltage	1.8V
DC Power	11.9mW
Control Voltage (V_{tune})	0.532-0.929 V
Freq. Tuning Range	0.55-3.8 GHz
Output Power	+3 ~ -11 dBm
Phase Noise @ 1MHz Offset	-89 dBc/Hz

Table II. Performance comparison of the proposed VCO and recently works

Parameter	Unit	This Work	[12]	[13]	[14]
Technology	μm -CMOS	0.18	0.18	0.18	0.18
Supply Voltage	V	1.8	1.8	1.8	1.8
Tuning Range	GHz	0.55-3.8	0.5-3	0.5-2	0.4-1.6
	%	149	143	120	120
Power Dissipation	mW	11.9	6-28	13.8	26
Output Power	dBm	+3 ~ -11	-14 ~ -22	-21 ~ -29	N.A.
Phase Noise @ 1MHz Offset	dBc/Hz	-78 ~ -89	-101 ~ -118	-78 ~ -90	-88 ~ -95
Wide Tuning Range Technique	-	Active Inductor	Active Inductor	Active Inductor	Ring Oscillator

4. CONCLUSION

A new wide tuning range Colpitts VCO in 0.18 μm CMOS process is introduced in this paper. In order to achieve a wide tuning range and small die area, in this structure, a tunable active inductor is used as a part of LC tank. Simulation results indicate that the proposed VCO has a wide tuning range of 149% and is a good choice for design wide locking rang ILFDs.

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